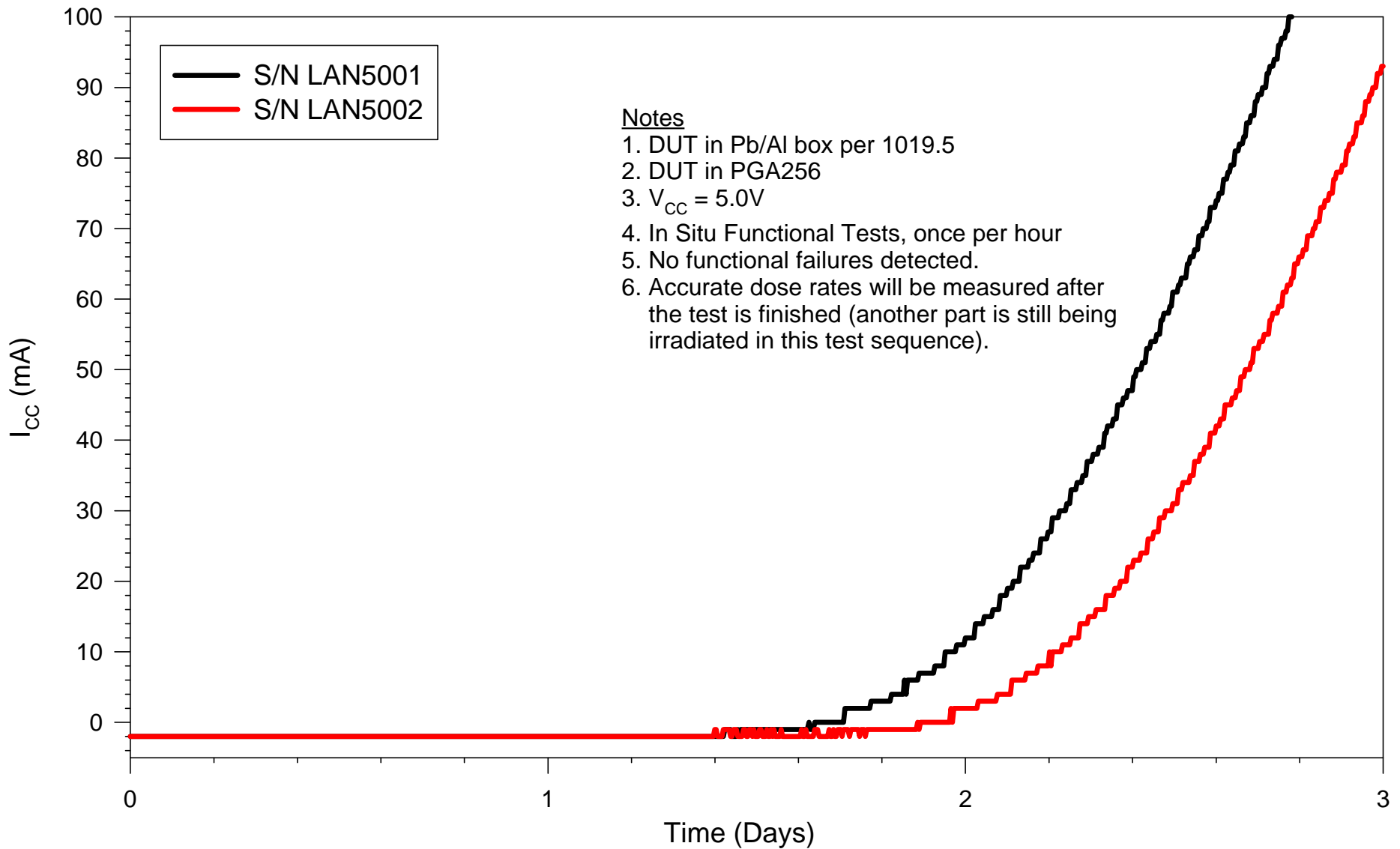


QYH580 TID Experiment
0.8 μm
L/C 713B50-656 - S/N LAN50xx
~ 6 krad(Si)/day
NASA GSFC
April 16, 2001



Notes

1. DUT in Pb/Al box per 1019.5
2. DUT in PGA256
3. $V_{CC} = 5.0\text{V}$
4. In Situ Functional Tests, once per hour
5. No functional failures detected.
6. Accurate dose rates will be measured after the test is finished (another part is still being irradiated in this test sequence).